

EPSA12 B B J D -3.6864M TR

Series —
ROHS Compliant (Pb-free) 2.5V 4 Pad 5mm x 7mm
Ceramic SMD LVCMOS Programmable Spread
Spectrum Oscillator

Frequency Tolerance/Stability — ±50ppm Maximum

Operating Temperature Range --40°C to +85°C

Packaging Options
Tape & Reel
Nominal Frequency
3.6864MHz

Spread Spectrum
±1.00% Center Spread

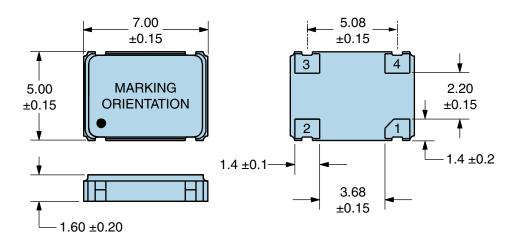
Output Control Function
 Power Down

Frequency Tolerance/Stability ±50ppm Maximum (Inclusive of all conditions: Frequency Stability over the Operating Temperature Range, Supply Voltage Change, Output Load Change, First Year Aging at 25°C, Shock, and Vibration.) Operating Temperature Range 40°C to +85°C Supply Voltage 2.5Vdc ±5% Maximum Supply Voltage -0.5Vdc to +3.2Vdc Input Current 15mA Maximum Output Voltage Logic High (Voh) 90% of Vdd Minimum (IOH=-8mA) Output Voltage Logic Low (Vol) 10% of Vdd Maximum (IOL=+8mA) Rise/Fall Time 3nSec Maximum (Measured at 10% to 90% of Waveform) Duty Cycle 50% ±5(%) (Measured at 50% of waveform) Load Drive Capability 15pF Maximum Output Logic Type CMOS Output Control Function Power Down Input Voltage (Vih and Vil) Power Down Output Disable Time 100nSec Maximum Standby Current 10µA Maximum (Unloaded; Pad 1=Ground) \$pread Spectrum #1.00% Center Spread Modulation Frequency 30kHz Minimum, 32kHz Typical, 45kHz Maximum Period Jitter 10mSec Maximum (Cycle to Cycle; Spread Spectrum-On) Start Up Time	ELECTRICAL SPECIFICAT	TIONS CONTRACTOR OF THE PROPERTY OF THE PROPER
Supply Voltage Change, Output Load Change, First Year Aging at 25°C, Shock, and Vibration.) Operating Temperature Range	Nominal Frequency	3.6864MHz
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Output Voltage Logic High (Voh) Output Voltage Logic Low (Vol) Rise/Fall Time 3nSec Maximum (Measured at 10% to 90% of Waveform) Duty Cycle 50% ±5(%) (Measured at 50% of waveform) Load Drive Capability 15pF Maximum Output Logic Type CMOS Output Control Function Power Down Input Voltage (Vih and Vil) Power Down Output Disable Time 100nSec Maximum Town Output Logic Type 100nSec Maximum 100nSec Maximum 100nSec Maximum Standby Current 10µA Maximum (Unloaded; Pad 1=Ground) \$\$Fread Spectrum \$\$1.00% Center Spread Modulation Frequency 30kHz Minimum, 32kHz Typical, 45kHz Maximum Period Jitter 10mSec Maximum 10mSec Maximum (Cycle to Cycle; Spread Spectrum-On) Start Up Time	Maximum Supply Voltage	-0.5Vdc to +3.2Vdc
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Period Jitter 100pSec Maximum (Cycle to Cycle; Spread Spectrum-On) Start Up Time 10mSec Maximum	Spread Spectrum	±1.00% Center Spread
Start Up Time 10mSec Maximum	Modulation Frequency	30kHz Minimum, 32kHz Typical, 45kHz Maximum
The state of the s	Period Jitter	100pSec Maximum (Cycle to Cycle; Spread Spectrum-On)
Storage Temperature Range -55°C to +125°C	Start Up Time	10mSec Maximum
	Storage Temperature Range	-55°C to +125°C

ENVIRONMENTAL & MECHANICAL SPECIFICATIONS		
ESD Susceptibility	MIL-STD-883, Method 3015, Class 1, HBM: 1500V	
Fine Leak Test	MIL-STD-883, Method 1014, Condition A	
Flammability	UL94-V0	
Gross Leak Test	MIL-STD-883, Method 1014, Condition C	
Mechanical Shock	MIL-STD-883, Method 2002, Condition B	
Moisture Resistance	MIL-STD-883, Method 1004	
Moisture Sensitivity	J-STD-020, MSL 1	
Resistance to Soldering Heat	MIL-STD-202, Method 210, Condition K	
Resistance to Solvents	MIL-STD-202, Method 215	
Solderability	MIL-STD-883, Method 2003	
Temperature Cycling	MIL-STD-883, Method 1010, Condition B	
Vibration	MIL-STD-883, Method 2007, Condition A	



MECHANICAL DIMENSIONS (all dimensions in millimeters)



PIN	CONNECTION
1	Power Down
2	Case Ground
3	Output
4	Supply Voltage

LINE	MARKING
1	ECLIPTEK
2	3.6864M
3	SXXXXX S=Configuration Designator XXXXX=Ecliptek Manufacturing Identifier

Suggested Solder Pad Layout

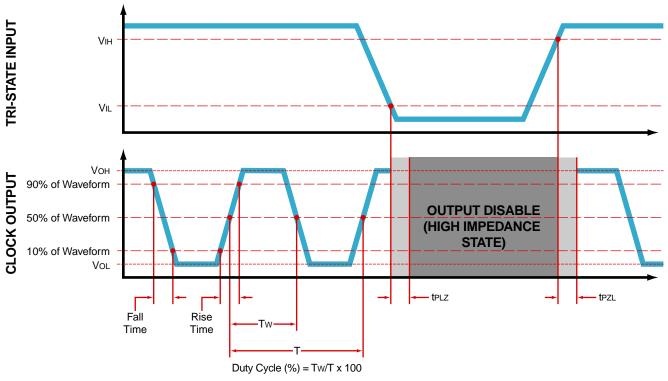
All Dimensions in Millimeters



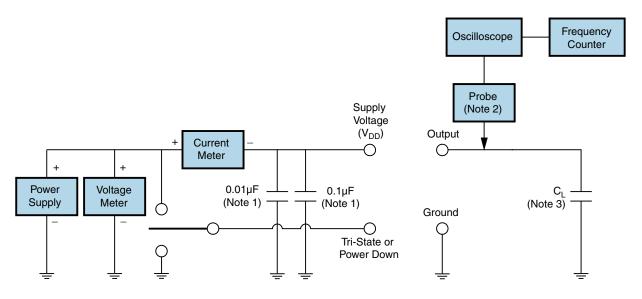
All Tolerances are ±0.1



OUTPUT WAVEFORM & TIMING DIAGRAM



Test Circuit for CMOS Output

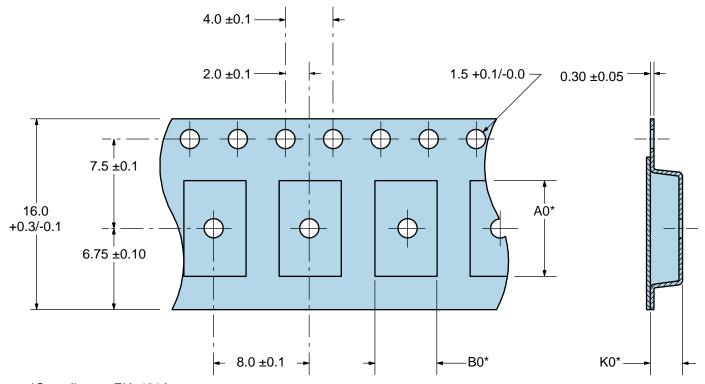


- Note 1: An external 0.01µF ceramic bypass capacitor in parallel with a 0.1µF high frequency ceramic bypass capacitor close (less than 2mm) to the package ground and supply voltage pin is required.
- Note 2: A low input capacitance (<12pF), 10X Attentuation Factor, High Impedance (>10Mohms), and High bandwidth (>300MHz) passive probe is recommended.
- Note 3: Capacitance value CL includes sum of all probe and fixture capacitance. See applicable specification sheet for 'Load Drive Capability'.

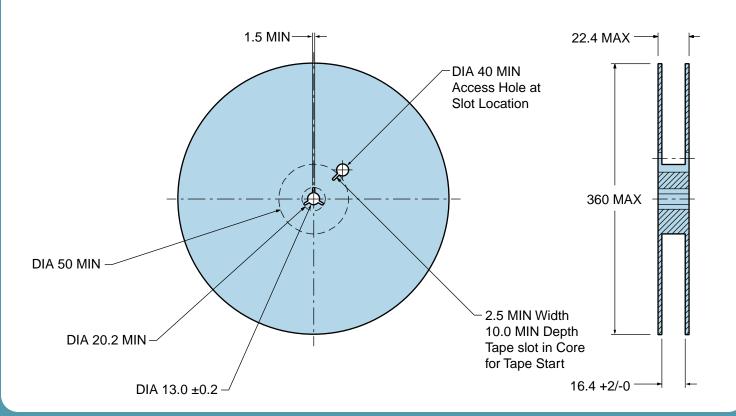


Tape & Reel Dimensions

Quantity Per Reel: 1,000 Units



*Compliant to EIA 481A





Recommended Solder Reflow Methods



High Temperature Infrared/Convection

<u> </u>	
T _s MAX to T _∟ (Ramp-up Rate)	3°C/second Maximum
Preheat	
- Temperature Minimum (T _S MIN)	150°C
- Temperature Typical (T _s TYP)	175°C
- Temperature Maximum (T _s MAX)	200°C
- Time (t _s MIN)	60 - 180 Seconds
Ramp-up Rate (T _L to T _P)	3°C/second Maximum
Time Maintained Above:	
- Temperature (T∟)	217°C
- Time (t∟)	60 - 150 Seconds
Peak Temperature (T _P)	260°C Maximum for 10 Seconds Maximum
Target Peak Temperature (T _P Target)	250°C +0/-5°C
Time within 5°C of actual peak (tp)	20 - 40 seconds
Ramp-down Rate	6°C/second Maximum
Time 25°C to Peak Temperature (t)	8 minutes Maximum
Moisture Sensitivity Level	Level 1
Additional Notes	Temperatures shown are applied to body of device.



Recommended Solder Reflow Methods



Low Temperature Infrared/Convection 240°C

T _s MAX to T _L (Ramp-up Rate)	5°C/second Maximum
Preheat	
- Temperature Minimum (T _s MIN)	N/A
- Temperature Typical (T _s TYP)	150°C
- Temperature Maximum (T _s MAX)	N/A
- Time (t _s MIN)	60 - 120 Seconds
Ramp-up Rate (T _L to T _P)	5°C/second Maximum
Time Maintained Above:	
- Temperature (T _L)	150°C
- Time (t∟)	200 Seconds Maximum
Peak Temperature (T _P)	240°C Maximum
Target Peak Temperature (T _P Target)	240°C Maximum 1 Time / 230°C Maximum 2 Times
Time within 5°C of actual peak (tp)	10 seconds Maximum 2 Times / 80 seconds Maximum 1 Time
Ramp-down Rate	5°C/second Maximum
Time 25°C to Peak Temperature (t)	N/A
Moisture Sensitivity Level	Level 1
Additional Notes	Temperatures shown are applied to body of device.

Low Temperature Manual Soldering

185°C Maximum for 10 seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)

High Temperature Manual Soldering

260°C Maximum for 5 seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)